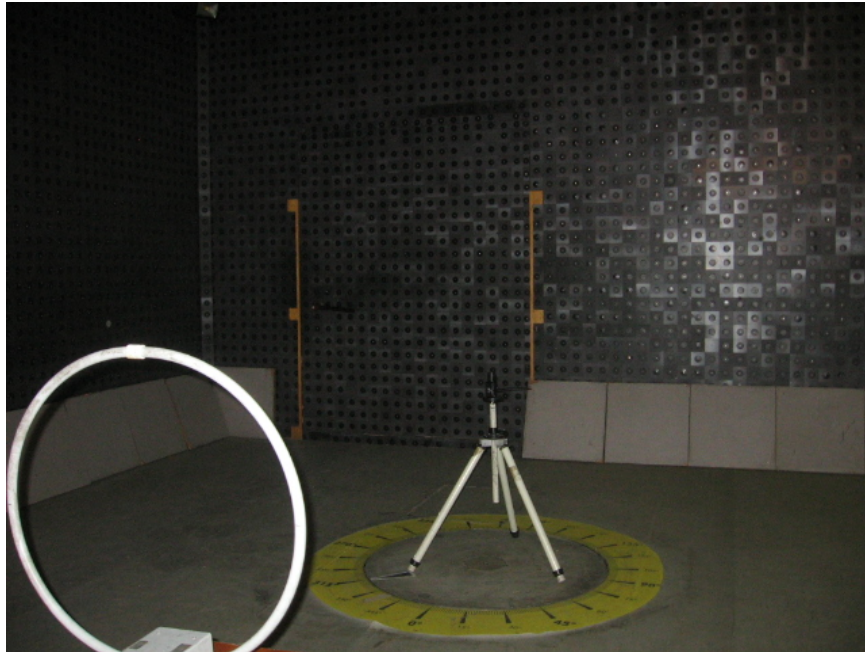


SETUP PHOTOGRAPHS

This document contains 7 photographs

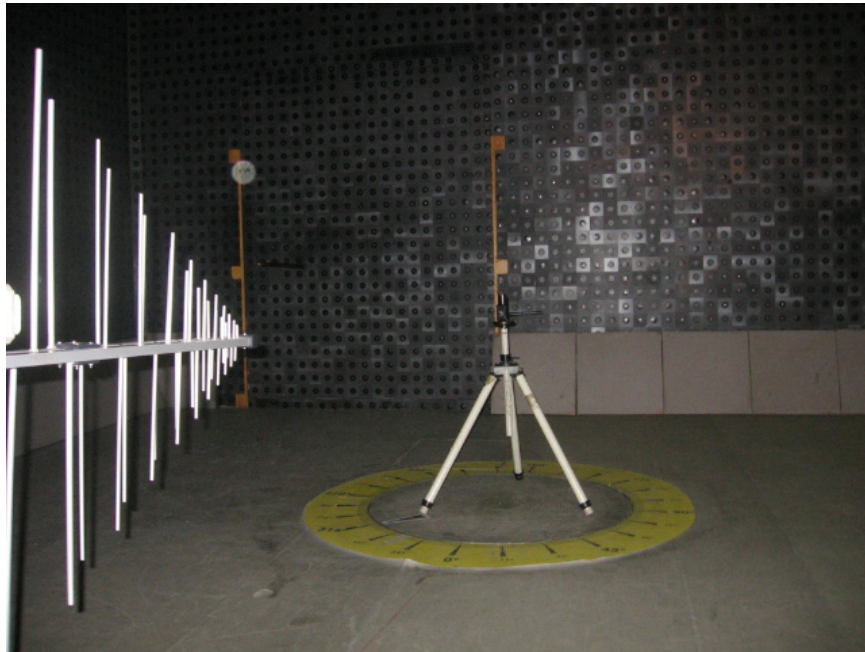
Photograph No.1

Setup for spurious emission field strength measurements in the anechoic chamber below 30 MHz

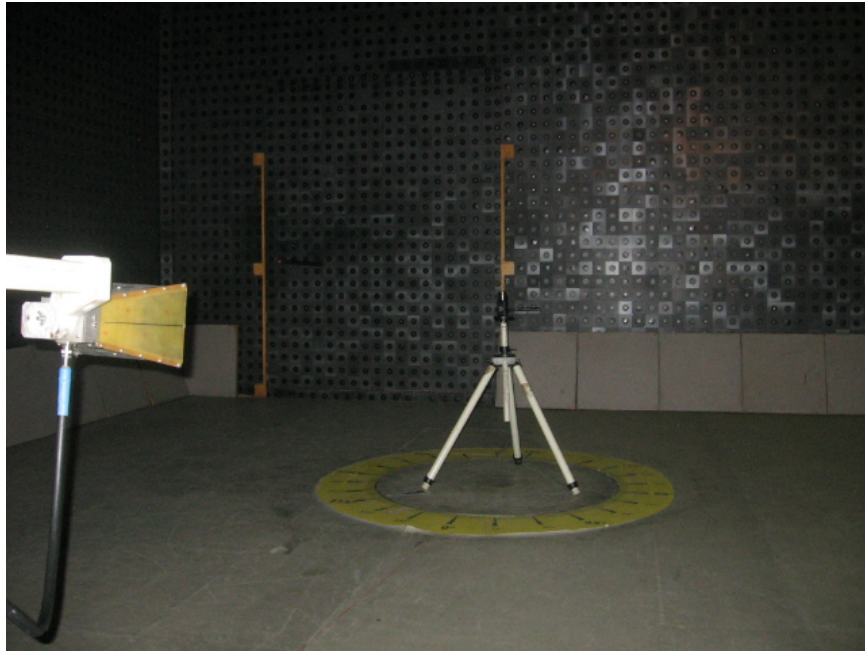


Photograph No.2

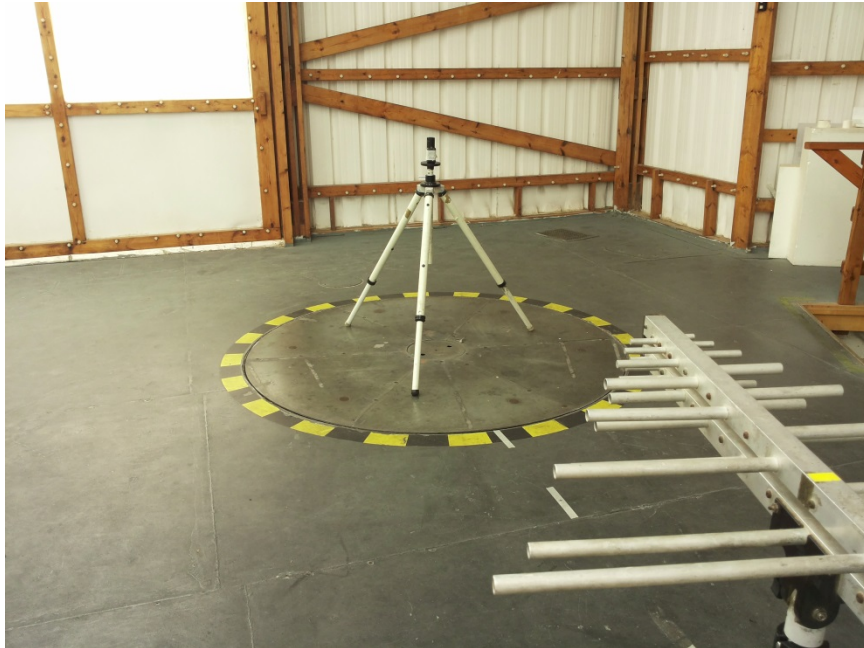
Setup for carrier field strength, spurious emission field strength measurements in the anechoic chamber in 30 – 1000 MHz range



Photograph No.3
Setup for spurious emission field strength measurements in the anechoic chamber
above 1000 MHz range



Photograph No.4
Setup for carrier and band edge emission field strength measurements at the OATS
in 30 - 1000 MHz range



Photograph No.5
Setup for carrier and band edge emission field strength measurements at the OATS
above 1000 MHz range



Photograph No.6
Setup for field strength measurements at the OATS, EUT in X-axis orthogonal position close view



The image shows a laboratory setup for signal generation and analysis. On the left is an Agilent E6640A signal generator, which is displaying a sine wave on its screen. The screen shows a frequency of 18.37 MHz and an amplitude of -14.48 dBm. On the right is a spectrum analyzer, which is displaying a frequency spectrum with a peak at 18.37 MHz. A cable connects the two devices. In the foreground, a keyboard and a mouse are visible.